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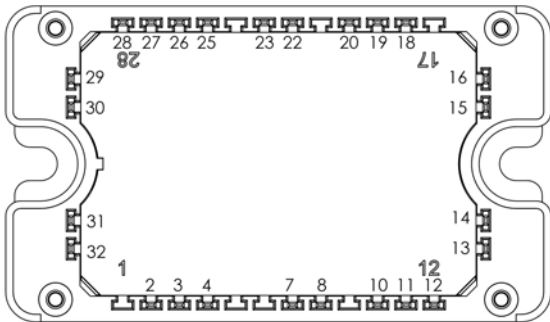
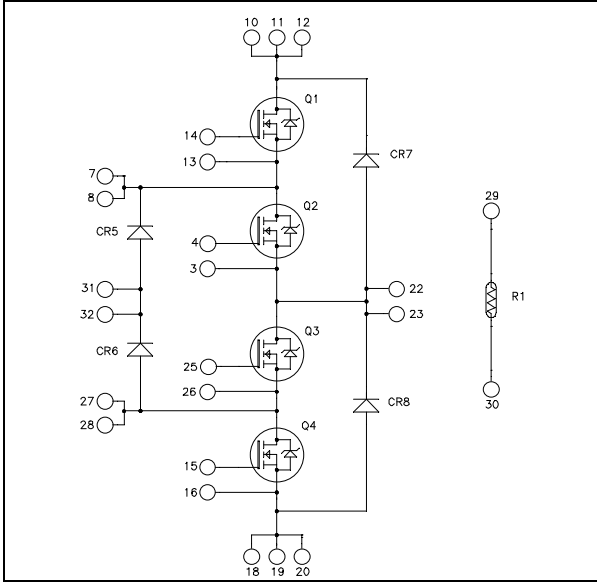
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Three level inverter  
SiC MOSFET Power Module

**SiC Power MOSFET :**  
 $V_{DSS} = 1200V$  ;  $R_{DS(on)} = 40m\Omega$  @  $T_j = 25^\circ C$



All multiple inputs and outputs must be shorted together  
 10/11/12 ; 7/8 ; 27/28 ; ...

**All ratings @  $T_j = 25^\circ C$  unless otherwise specified**

**Q1 to Q4 Absolute maximum ratings** (per SiC MOSFET)

Symbol	Parameter	Max ratings	Unit
$V_{DSS}$	Drain - Source Breakdown Voltage	1200	V
$I_D$	Continuous Drain Current	$T_c = 25^\circ C$	48
		$T_c = 80^\circ C$	38
$I_{DM}$	Pulsed Drain current	100	A
$V_{GS}$	Gate - Source Voltage	-6/+23	V
$V_{GSOP}$	Gate - Source Voltage, recommended operation values	-5/18	V
$R_{DSon}$	Drain - Source ON Resistance	52	m $\Omega$
$P_D$	Power Dissipation	$T_c = 25^\circ C$ 263	W

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

**Application**

- Uninterruptible Power Supplies

**Features**

- **SiC Power MOSFET**
  - Low  $R_{DS(on)}$
  - High temperature performance
- **SiC Schottky Diode**
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature Independent switching behavior
  - Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring
- AlN substrate for improved thermal performance

**Benefits**

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

**Q1 to Q4 Electrical Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V ; V_{DS} = 1200V$		10	100	$\mu A$
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 20V ; I_D = 40A ; T_j = 25^\circ C$		40	52	m $\Omega$
		$V_{GS} = 18V ; I_D = 40A ; T_j = 175^\circ C$		90		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 10mA$	2		4	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20V, V_{DS} = 0V$			250	nA

**Q1 to Q4 Dynamic Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 1000V$ $f = 1MHz$		1893		pF
$C_{oss}$	Output Capacitance			150		
$C_{rss}$	Reverse Transfer Capacitance			10		
$Q_g$	Total gate Charge	$V_{GS} = -5/20V$ $V_{Bus} = 800V$ $I_D = 40A$		115		nC
$Q_{gs}$	Gate – Source Charge			28		
$Q_{gd}$	Gate – Drain Charge			37		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -5/+20V$ $V_{Bus} = 800V$ $I_D = 40A$ $R_L = 20\Omega ; R_G = 25\Omega$		12		ns
$T_r$	Rise Time			14		
$T_{d(off)}$	Turn-off Delay Time			23		
$T_f$	Fall Time			18		
$E_{on}$	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$ $I_D = 40A$ $R_G = 25\Omega$	$T_j = 150^\circ C$		0.9	mJ
$E_{off}$	Turn off Energy			$T_j = 150^\circ C$		0.5
$R_{Gint}$	Internal gate resistance			1.8		$\Omega$
$R_{thJC}$	Junction to Case Thermal Resistance				0.57	$^\circ C/W$

**CR5 & CR6 SiC diode ratings and characteristics** (Per SiC diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$V_{RRM}$	Peak Repetitive Reverse Voltage				600	V	
$I_{RM}$	Reverse Leakage Current	$V_R = 600V$	$T_j = 25^\circ C$		30	180	$\mu A$
			$T_j = 175^\circ C$		60	900	
$I_F$	DC Forward Current			30		A	
$V_F$	Diode Forward Voltage	$I_F = 30A$	$T_j = 25^\circ C$		1.6	1.8	V
			$T_j = 175^\circ C$		2	2.4	
$Q_C$	Total Capacitive Charge	$I_F = 30A, V_R = 600V$ $di/dt = 1000A/\mu s$		84		nC	
C	Total Capacitance	$f = 1MHz, V_R = 200V$		195		pF	
		$f = 1MHz, V_R = 400V$		150			
$R_{thJC}$	Junction to Case Thermal Resistance				0.8	$^\circ C/W$	



# APTMC60TLM55CT3AG

Power Matters.™

## CR7 & CR8 SiC diode ratings and characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage				1200	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =1200V	T <sub>j</sub> = 25°C	96	600	μA
			T <sub>j</sub> = 175°C	168	3000	
I <sub>F</sub>	DC Forward Current		T <sub>c</sub> = 125°C	30		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 30A	T <sub>j</sub> = 25°C	1.6	1.8	V
			T <sub>j</sub> = 175°C	2.3	3	
Q <sub>C</sub>	Total Capacitive Charge	I <sub>F</sub> = 30A, V <sub>R</sub> = 1200V di/dt = 1500A/μs		240		nC
C	Total Capacitance	f = 1MHz, V <sub>R</sub> = 200V		288		pF
		f = 1MHz, V <sub>R</sub> = 400V		207		
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.50	°C/W

## Temperature sensor NTC (see application note APT0406 on www.microsemi.com)

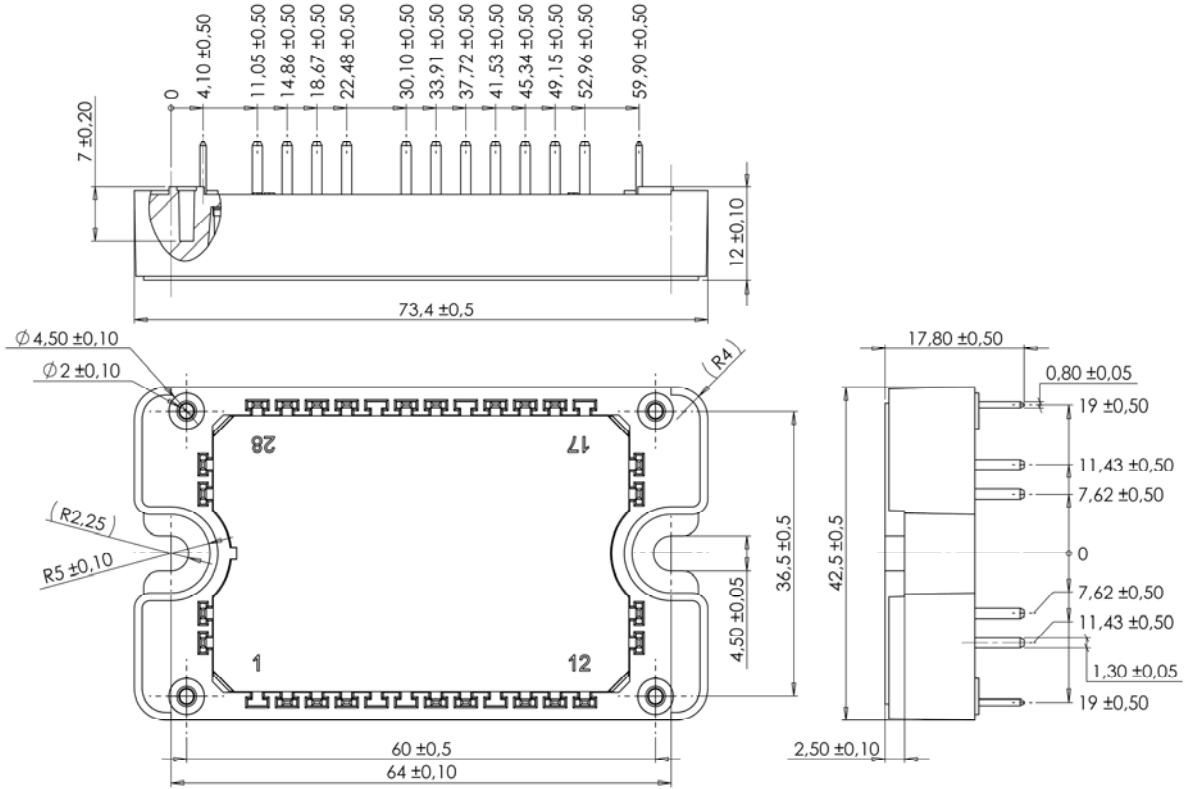
Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
ΔR <sub>25</sub> /R <sub>25</sub>			5		%
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K		3952		K
ΔB/B		T <sub>C</sub> =100°C	4		%

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

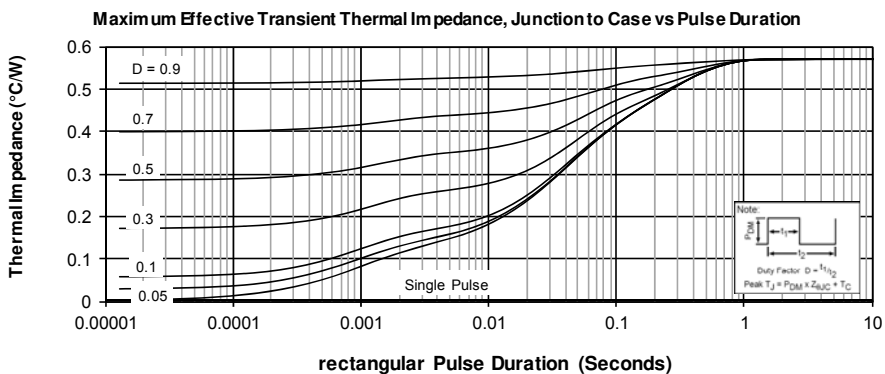
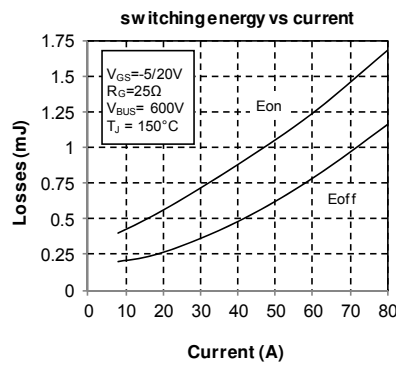
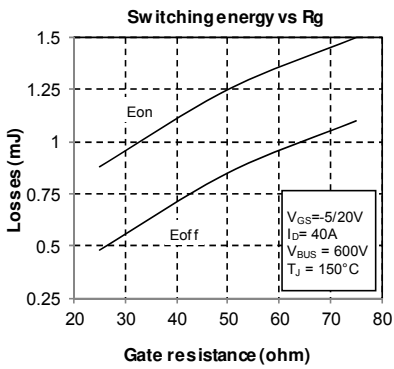
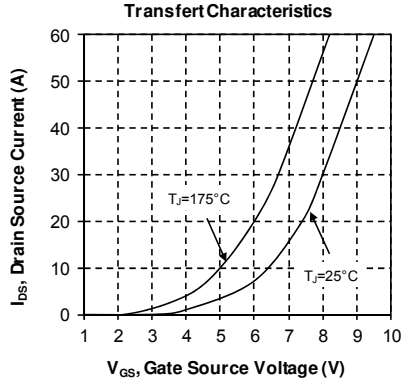
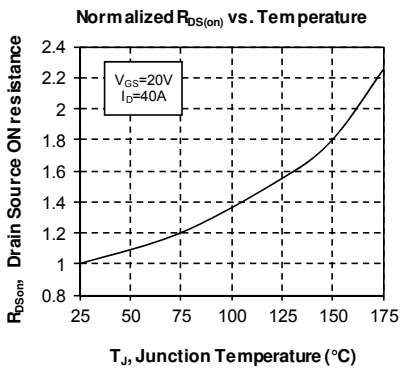
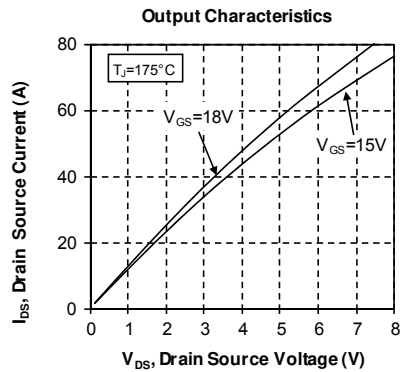
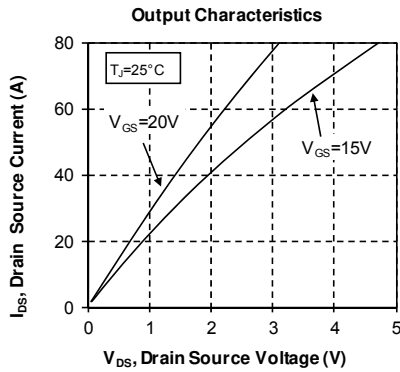
## Thermal and package characteristics

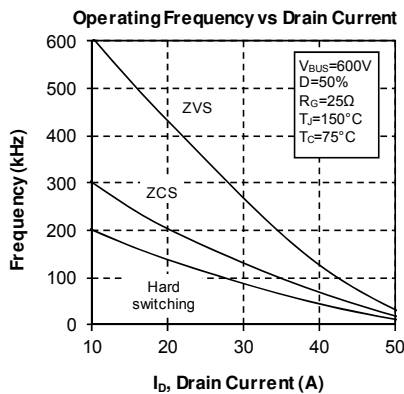
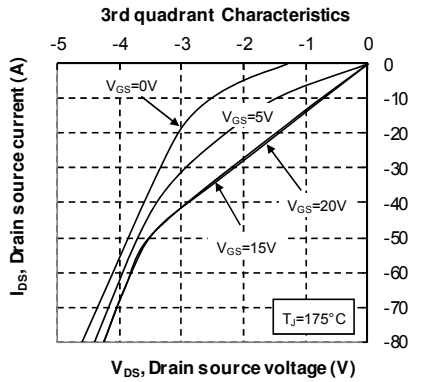
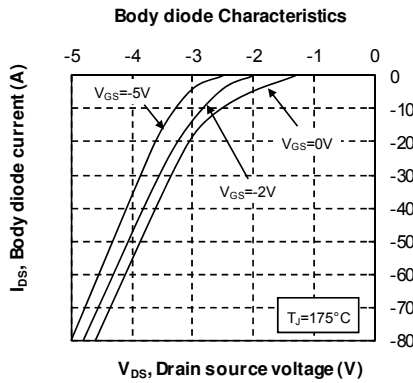
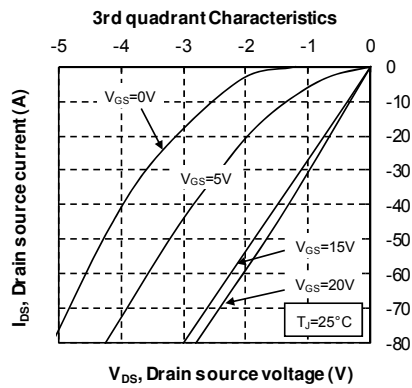
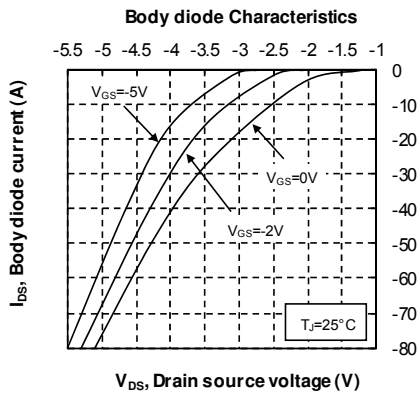
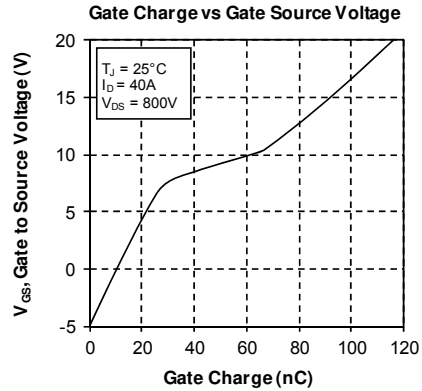
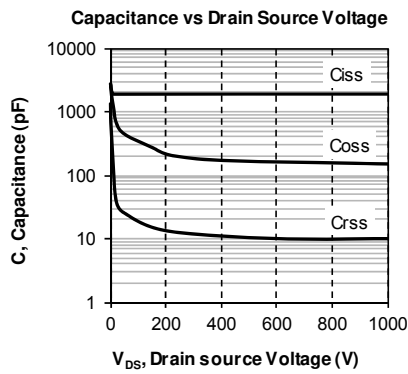
Symbol	Characteristic	Min	Max	Unit		
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000		V		
T <sub>J</sub>	Operating junction temperature range	-40	175	°C		
T <sub>JOP</sub>	Recommended junction temperature under switching conditions	-40	T <sub>Jmax</sub> -25			
T <sub>STG</sub>	Storage Temperature Range	-40	125			
T <sub>C</sub>	Operating Case Temperature	-40	125			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

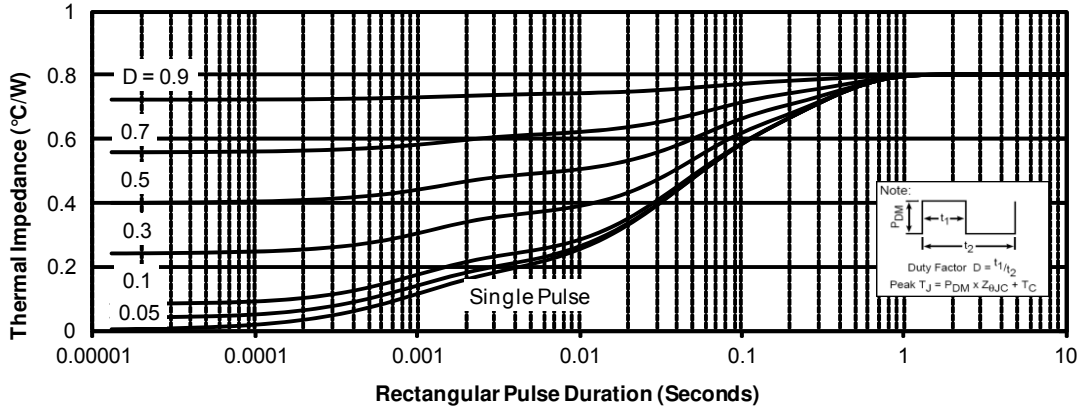
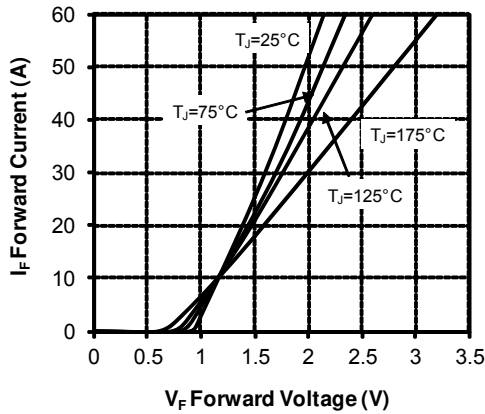
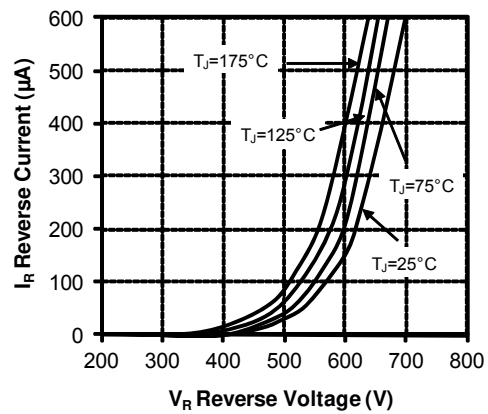
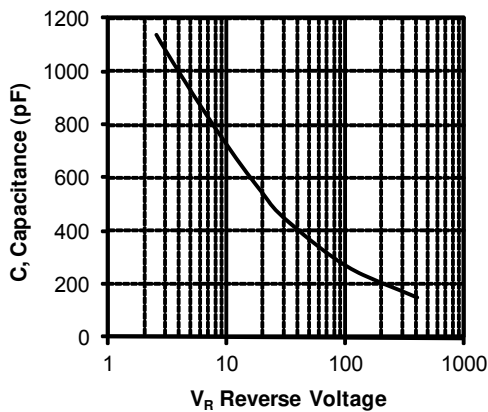
**Package outline (dimensions in mm)**


See application note 1906 - Mounting Instructions for SP3F Power Modules on [www.microsemi.com](http://www.microsemi.com)

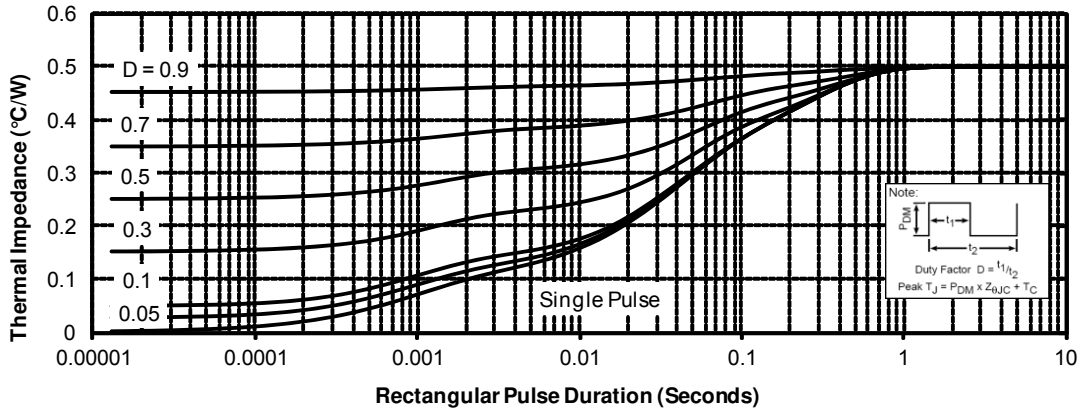
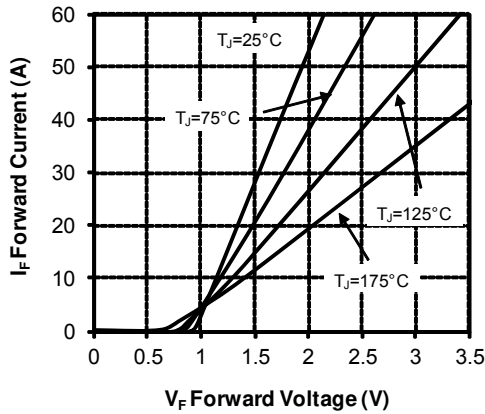
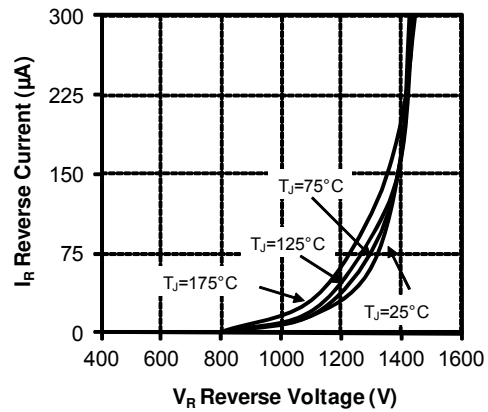
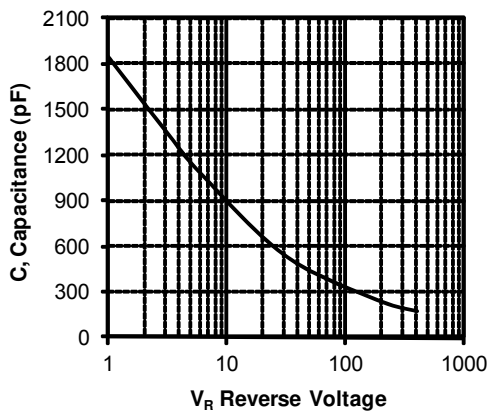
## Q1 to Q4 Typical performance curve





**CR5 & CR6 Typical performance curve**
**Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration**

**Forward Characteristics**

**Reverse Characteristics**

**Capacitance vs. Reverse Voltage**




**CR7 & CR8 Typical performance curve**
**Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration**

**Forward Characteristics**

**Reverse Characteristics**

**Capacitance vs. Reverse Voltage**


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